Search Notes

Application/Control No.	Applica Reexam
00/052 245	CLUME

09/853,315 Examiner

Betsy L. Deppe

Applicant(s)/Patent under Reexamination
GUINEA ET AL.
Art Unit

2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	229	6/29/2005	BD		
375	230	6/29/2005	BD		
375	232	6/29/2005	BD		
375	257	6/29/2005	BD		
333	18	6/29/2005	BD		
333	28R	6/29/2005	BD		
379	398	6/29/2005	BD		
379	400	6/29/2005	BD		
708	322	6/30/2005	BD		
708	323	6/30/2005	BD		
375	350	7/5/2005	BD		
Updated	search	3/22/2006	BD		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
above	3/22/2006	BD			
	Subclass	Subclass Date			

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Inventor name search	6/29/2005	BD
Text search (USPAT; US-PGPUB)	6/29/2005	BD
Text search (USPAT; US-PGPUB)	6/30/2005	BD
Text search (USPAT; US-PGPUB)	7/5/2005	BD
Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB)	3/22/2006	BD